

**Notice of References Cited**

Application/Control No.

10/775,791

Applicant(s)/Patent Under  
Reexamination  
KESAL ET AL.

Examiner

Esteve Mede

Art Unit

2137

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,754,492 A	06-1988	Malvar, Henrique S.	382/268
*	B	US-5,040,217 A	08-1991	Brandenburg et al.	704/200.1
*	C	US-5,142,656 A	08-1992	Fielder et al.	704/229
*	D	US-5,172,189 A	12-1992	Mitome, Noriyuki	356/401
*	E	US-5,479,562 A	12-1995	Fielder et al.	704/229
*	F	US-5,726,758 A	03-1998	Hasegawa et al.	356/401
*	G	US-6,330,672 B1	12-2001	Shur, David Hilton	713/176
*	H	US-2001/0049788 A1	12-2001	SHUR, DAVID HILTON	713/179
*	I	US-2002/0061121 A1	05-2002	Rhoads et al.	382/100
*	J	US-6,421,802 B1	07-2002	Schildbach et al.	714/747
*	K	US-2002/0136427 A1	09-2002	Staring et al.	382/100
*	L	US-2002/0159614 A1	10-2002	Bradley et al.	382/100
*	M	US-2003/0009669 A1	01-2003	White et al.	713/176

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	A.Z Tirkel et al., "A two-Dimensional Digital Watermark", 1995, Monash University
	V	Les Atlas, "Modulation Spectral Transforms Application to Speech Separation and Modification", June 27, 2003, The Institute of Electronics, Information and Communication Engineers, page 1-5.
	W	Doser et al., "Time/Frequency Techniques for Signal feature Detection", 1999, IEEE.
	X	Li Zhi Cheng, "On Computer the Two-Dimensional (2-D) Type IV Discrete Cosine Transform (2-D DCT-IV)", August 8, 2001, IEEE

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/775,791	Applicant(s)/Patent Under Reexamination KESAL ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0028381 A1	02-2003	Tucker et al.	704/273
*	B	US-2003/0093282 A1	05-2003	Goodwin, Michael M.	704/500
*	C	US-2003/0217272 A1	11-2003	Agrawal et al.	713/176
*	D	US-2004/0042635 A1	03-2004	Epstein et al.	382/100
*	E	US-2004/0101160 A1	05-2004	Kunisa, Akiomi	382/100
*	F	US-2004/0158724 A1	08-2004	Carr et al.	713/186
*	G	US-6,794,996 B2	09-2004	Tsutsui et al.	341/50
*	H	US-2005/0207325 A1	09-2005	Sako et al.	369/275.3
*	I	US-2005/0226603 A1	10-2005	Hirabayashi et al.	386/095
*	J	US-6,968,014 B1	11-2005	Bobier, Joseph A.	375/271
*	K	US-6,963,842 B2	11-2005	Goodwin, Michael M.	704/500
*	L	US-6,971,024 B1	11-2005	Sako et al.	713/193
*	M	US-2006/0080538 A1	04-2006	Kusuda et al.	713/176

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,035,775 B2	04-2006	Abe et al.	702/189
*	B	US-7,065,491 B2	06-2006	Tsai et al.	704/500
*	C	US-2006/0167683 A1	07-2006	Hoerich et al.	704/230
*	D	US-2006/0217968 A1	09-2006	Burges et al.	704/205
*	E	US-2007/0092108 A1	04-2007	Alattar et al.	382/100
*	F	US-7,248,934 B1	07-2007	Rossum et al.	700/94
*	G	US-7,260,488 B2	08-2007	Abe et al.	702/66
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	T					

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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